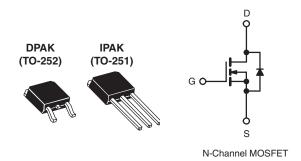
## **Power MOSFET**

| PRODUCT SUMMARY                 |                             |  |  |  |  |
|---------------------------------|-----------------------------|--|--|--|--|
| V <sub>DS</sub> (V)             | 60                          |  |  |  |  |
| $R_{DS(on)}\left(\Omega\right)$ | V <sub>GS</sub> = 10 V 0.10 |  |  |  |  |
| Q <sub>g</sub> (Max.) (nC)      | 25                          |  |  |  |  |
| Q <sub>gs</sub> (nC)            | 5.8                         |  |  |  |  |
| Q <sub>gd</sub> (nC)            | 11                          |  |  |  |  |
| Configuration                   | Single                      |  |  |  |  |



### **FEATURES**

- · Dynamic dV/dt Rating
- Surface Mount (IRFR024/SiHFR024)
- Straight Lead (IRFU024/SiHFU024)
- · Available in Tape and Reel
- Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Lead (Pb)-free Available

### **DESCRIPTION**

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The DPAK is designed for surface mounting using vapor phase, infrared, or wave soldering techniques. The straight lead version (IRFU/SiHFU series) is for through-hole mounting applications. Power dissipation levels up to 1.5 W are possible in typical surface mount applications.

| ORDERING INFORMATION |               |                           |                         |               |  |  |
|----------------------|---------------|---------------------------|-------------------------|---------------|--|--|
| Package              | DPAK (TO-252) | DPAK (TO-252)             | DPAK (TO-252)           | IPAK (TO-251) |  |  |
| Lead (Pb)-free       | IRFR024PbF    | IRFR024TRPbFa             | -                       | IRFU024PbF    |  |  |
|                      | SiHFR024-E3   | SiHFR024T-E3 <sup>a</sup> | -                       | SiHFU024-E3   |  |  |
| SnPb                 | IRFR024       | IRFR024TR <sup>a</sup>    | IRFR024TRL <sup>a</sup> | IRFU024       |  |  |
| 51170                | SiHFR024      | SiHFR024T <sup>a</sup>    | SiHFR024TL <sup>a</sup> | SiHFU024      |  |  |

### Note

a. See device orientation.

| PARAMETER                                       |                         |   | SYMBOL          | LIMIT | UNIT  |
|---|-------------------------|---|-----------------|-------|-------|
| Drain-Source Voltage                            |                         |   | V <sub>DS</sub> | 60    | V     |
| Gate-Source Voltage                             |                         |   | V <sub>GS</sub> | ± 20  | v     |
| Continuous Drain Current                        | V at 10 V               | $T_{\rm C} = 25 ^{\circ}{\rm C}$<br>$T_{\rm C} = 100 ^{\circ}{\rm C}$ |                 | 14    |       |
| Continuous Drain Current                        | V <sub>GS</sub> at 10 V | T <sub>C</sub> = 100 °C   | I <sub>D</sub>  | 9.0   | А     |
| Pulsed Drain Currenta                           |                         |   | I <sub>DM</sub> | 56    |       |
| Linear Derating Factor                          |                         |   |                 | 0.33  | W/°C  |
| Linear Derating Factor (PCB Mount) <sup>e</sup> |                         |   |                 | 0.020 | VV/°C |
| Single Pulse Avalanche Energy <sup>b</sup>      |                         |   | E <sub>AS</sub> | 91    | mJ    |
| Maximum Power Dissipation                       | T <sub>C</sub> =        | T <sub>C</sub> = 25 °C P <sub>D</sub>                                 |                 | 42    | ١٨/   |
| Maximum Power Dissipation (PCB Mount)e          | T <sub>A</sub> =        | T <sub>A</sub> = 25 °C  |                 | 2.5   | W     |
| Peak Diode Recovery dV/dtc                      |                         |   | dV/dt           | 5.5   | V/ns  |

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFR024, IRFU024, SiHFR024, SiHFU024

# Vishay Siliconix



| <b>ABSOLUTE MAXIMUM RATINGS</b> T <sub>C</sub> = 25 °C, unless otherwise noted |                                   |               |                  |  |  |  |
|--|-----------------------------------|---------------|------------------|--|--|--|
| PARAMETER  | SYMBOL                            | LIMIT         | UNIT             |  |  |  |
| Operating Junction and Storage Temperature Range                               | T <sub>J</sub> , T <sub>stg</sub> | - 55 to + 150 | · °C             |  |  |  |
| Soldering Recommendations (Peak Temperature)                                   | for 10 s                          |               | 260 <sup>d</sup> |  |  |  |

#### **Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD}$  = 25 V, starting  $T_J$  = 25 °C, L = 541  $\mu$ H,  $R_G$  = 25  $\Omega$ ,  $I_{AS}$  = 14 A (see fig. 12).
- c.  $I_{SD} \leq$  17 A,  $dI/dt \leq$  110 A/ $\mu$ s,  $V_{DD} \leq$   $V_{DS}$ ,  $T_{J} \leq$  150 °C.
- d. 1.6 mm from case.
- e. When mounted on 1" square PCB (FR-4 or G-10 material).

| THERMAL RESISTANCE RATINGS                           |                   |      |      |      |      |  |
|--|-------------------|------|------|------|------|--|
| PARAMETER  | SYMBOL            | MIN. | TYP. | MAX. | UNIT |  |
| Maximum Junction-to-Ambient                          | R <sub>thJA</sub> | -    | -    | 110  |      |  |
| Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup> | R <sub>thJA</sub> | -    | -    | 50   | °C/W |  |
| Maximum Junction-to-Case (Drain)                     | R <sub>thJC</sub> | -    | -    | 3.0  |      |  |

#### Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

| PARAMETER                               | SYMBOL                | TES   | MIN.   | TYP. | MAX.  | UNIT  |      |
|---|-----------------------|---|--|------|-------|-------|------|
| Static                                  | - 1                   | -   |  |      |       |       |      |
| Drain-Source Breakdown Voltage          | V <sub>DS</sub>       | V <sub>GS</sub> =   | = 0 V, I <sub>D</sub> = 250 μA   | 60   | -     | -     | ٧    |
| V <sub>DS</sub> Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | Reference   | e to 25 °C, I <sub>D</sub> = 1 mA  | -    | 0.073 | -     | V/°C |
| Gate-Source Threshold Voltage           | V <sub>GS(th)</sub>   | V <sub>DS</sub> =   | V <sub>GS</sub> , I <sub>D</sub> = - 250 μA                                    | 2.0  | -     | 4.0   | ٧    |
| Gate-Source Leakage                     | I <sub>GSS</sub>      | ,   | V <sub>GS</sub> = ± 20 V   | -    | -     | ± 100 | nA   |
| Zana Cata Malhana Buain Commant         | ,                     | V <sub>DS</sub> :   | = 60 V, V <sub>GS</sub> = 0 V  | -    | -     | 25    |      |
| Zero Gate Voltage Drain Current         | I <sub>DSS</sub>      | V <sub>DS</sub> = 48 V  | V <sub>DS</sub> = 48 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C         |      | -     | 250   | μΑ   |
| Drain-Source On-State Resistance        | R <sub>DS(on)</sub>   | V <sub>GS</sub> = 10 V  | $I_D = 8.4 A^b$  | -    | -     | 0.10  | Ω    |
| Forward Transconductance                | 9 <sub>fs</sub>       | $V_{DS} = 25 \text{ V}, I_D = 8.4 \text{ A}^b$                    |  | 6.2  | -     | -     | S    |
| Dynamic                                 |                       |   |  |      |       |       |      |
| Input Capacitance                       | C <sub>iss</sub>      | V <sub>GS</sub> = 0 V,<br>V <sub>DS</sub> = 25 V,                 |  | -    | 640   | -     | pF   |
| Output Capacitance                      | C <sub>oss</sub>      |   |  | -    | 360   | -     |      |
| Reverse Transfer Capacitance            | C <sub>rss</sub>      | f = 1.  | f = 1.0 MHz, see fig. 5  |      | 79    | -     |      |
| Total Gate Charge                       | Qg                    |   |  | -    | -     | 25    | nC   |
| Gate-Source Charge                      | Q <sub>gs</sub>       | V <sub>GS</sub> = 10 V  | $I_D = 17 \text{ A}, V_{DS} = 48 \text{ V},$<br>see fig. 6 and 13 <sup>b</sup> | -    | -     | 5.8   |      |
| Gate-Drain Charge                       | $Q_{\mathrm{gd}}$     | 7   | occ ng. o and ro   | -    | -     | 11    |      |
| Turn-On Delay Time                      | t <sub>d(on)</sub>    |   |  | -    | 13    | -     |      |
| Rise Time                               | t <sub>r</sub>        | V <sub>DD</sub>   | V <sub>DD</sub> = 30 V, I <sub>D</sub> = 17A,                                  |      | 58    | -     | ns   |
| Turn-Off Delay Time                     | t <sub>d(off)</sub>   | $R_G = 18 \Omega$ , $R_D = 1.7 \Omega$ , see fig. $10^b$          |  | -    | 25    | -     |      |
| Fall Time                               | t <sub>f</sub>        |   |  | -    | 42    | -     |      |
| Internal Drain Inductance               | L <sub>D</sub>        | Between lead, 6 mm (0.25") from package and center of die contact |  | -    | 4.5   | -     | n⊔   |
| Internal Source Inductance              | L <sub>S</sub>        |   |  | -    | 7.5   | -     | - nH |

| <b>SPECIFICATIONS</b> T <sub>J</sub> = 25 °C, unless otherwise noted |                 |  |            |            |                      |      |  |
|--|-----------------|--|------------|------------|----------------------|------|--|
| PARAMETER  | SYMBOL          | TEST CONDITIONS  | MIN.       | TYP.       | MAX.                 | UNIT |  |
| Drain-Source Body Diode Characteristics                              |                 |  |            |            |                      |      |  |
| Continuous Source-Drain Diode Current                                | I <sub>S</sub>  | MOSFET symbol showing the  | -          | -          | 14                   | Α    |  |
| Pulsed Diode Forward Current <sup>a</sup>                            | I <sub>SM</sub> | integral reverse p - n junction diode  | -          | -          | 56                   | A    |  |
| Body Diode Voltage   | $V_{SD}$        | $T_J = 25  ^{\circ}\text{C}, \ I_S = 14  \text{A}, \ V_{GS} = 0  \text{V}^{\text{b}}$  | -          | -          | 1.5                  | V    |  |
| Body Diode Reverse Recovery Time                                     | t <sub>rr</sub> | T <sub>J</sub> = 25 °C, I <sub>F</sub> = 17 A, dl/dt = 100 A/μs <sup>b</sup>   | -          | 88         | 180                  | ns   |  |
| Body Diode Reverse Recovery Charge                                   | $Q_{rr}$        | $I_{J} = 25$ C, $I_{F} = 17$ A, $I_{J}$ A, $I_{J}$ C $I_{J}$ | -          | 0.29       | 0.64                 | μC   |  |
| Forward Turn-On Time   | t <sub>on</sub> | Intrinsic turn-on time is negligible (turn   | -on is don | ninated by | L <sub>S</sub> and L | _D)  |  |

#### **Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$  2 %.

### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

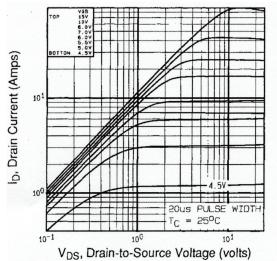


Fig. 1 - Typical Output Characteristics,  $T_C = 25$  °C

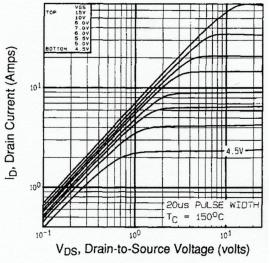


Fig. 2 - Typical Output Characteristics,  $T_C = 150$  °C

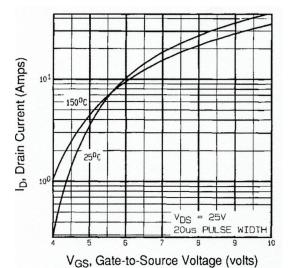


Fig. 3 - Typical Transfer Characteristics

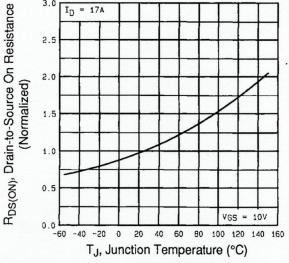


Fig. 4 - Normalized On-Resistance vs. Temperature

# IRFR024, IRFU024, SiHFR024, SiHFU024

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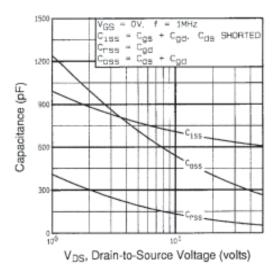


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

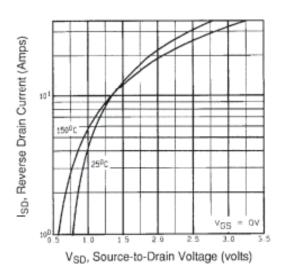


Fig. 7 - Typical Source-Drain Diode Forward Voltage

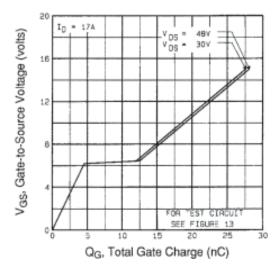


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

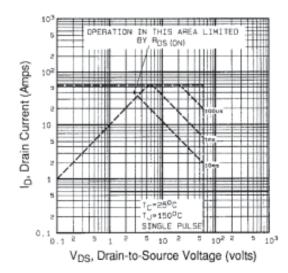


Fig. 8 - Maximum Safe Operating Area

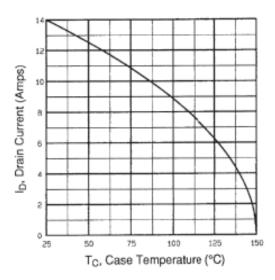


Fig. 9 - Maximum Drain Current vs. Case Temperature

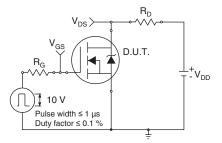


Fig. 10a - Switching Time Test Circuit

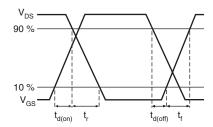


Fig. 10b - Switching Time Waveforms

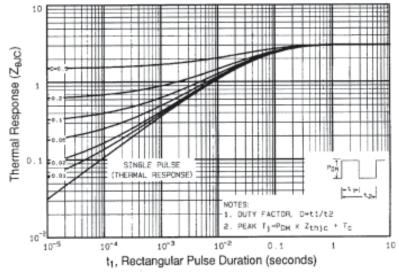


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



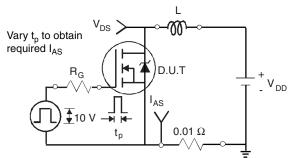


Fig. 12a - Unclamped Inductive Test Circuit

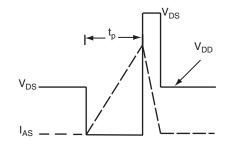


Fig. 12b - Unclamped Inductive Waveforms

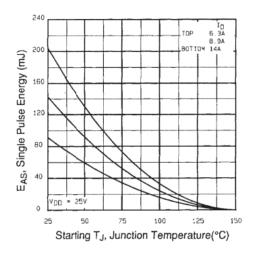


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

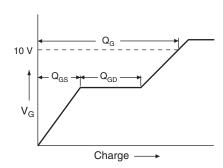


Fig. 13a - Basic Gate Charge Waveform

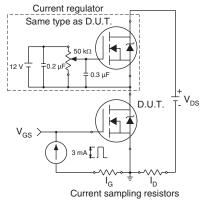
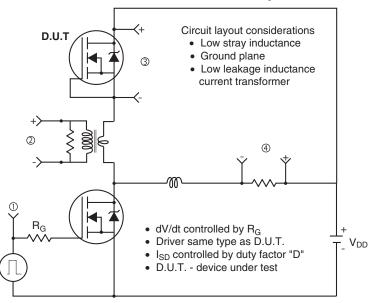
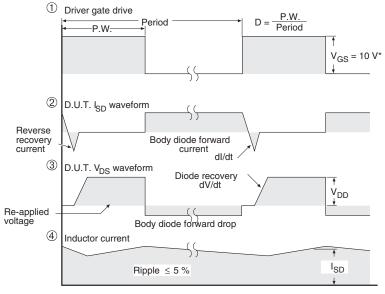


Fig. 13b - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit





\*  $V_{GS} = 5 V$  for logic level devices

Fig. 14 - For N-Channel

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